

**Search Notes**

Application/Control No.

10/635,172

Examiner

John P. Leubecker

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

3739

**SEARCHED**

Class	Subclass	Date	Examiner
600	114- 116,156,1 58,159,17 3,146	6/23/2005	JPL
600	152	6/23/2005	JPL
604	95.01		
604	95.03		
604	95.04		
604	95.05		
604	103.03		
73	865.8		
73	866.5		
606	108	↓	↓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Text Search	6/25/2005	JPL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner